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U. S. DEPARTMENT OF COMMERCE

PATENT AND TRADEMARK OFFICE

Sheet <u>1</u> of <u>1</u>

## LIST OF REFERENCES CITED BY APPLICANT

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4925-133PUS

Int'l Filing Date:

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Group Art:

Applicant:

Siamäk NAGHIAN et al.

## **U.S. PATENT DOCUMENTS**

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
ur fi	AC						
	AD						
	AE						

## FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
HB	AF	EP 0 889 663 A1	01/07/1999	EPO	Ishikawa et al.	H04Q	7/38	Yes
138	AG	EP 0 750 440 A2	12/27/1996	EPO	Ishikawa et al.	H04Q	7/38	Yes
#	АН	WO 99/23842	05/14/1999	PCT	Scholefield et al.	H04Q	7/20	Yes
	ΑI							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

AJ	
AK	
AL	

EXAMINER:	Muselon	DATE CONSIDERED: N/ /30 /84	
_	7/19		

<sup>\*</sup> EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.